DATA SHEET

NEC

MOS FIELD EFFECT TRANSISTOR
NP36P06KDG

SWITCHING
P-CHANNEL POWER MOSFET

DESCRIPTION

The NP36P06KDG is P-channel MOS Field Effect Transistor designed for high current switching applications.

<R> **ORDERING INFORMATION**

PART NUMBER	LEAD PLATING	PACKING	PACKAGE
NP36P06KDG-E1-AY [Note]	Pure Sn (Tin)	Tape 800 p/reel	TO-263 (MP-25ZK)
NP36P06KDG-E2-AY [Note]			

Note Pb-free (This product does not contain Pb in external electrode.)

FEATURES

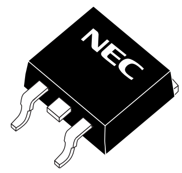
- Super low on-state resistance

  $R_{DS(on)1}$ = 29.5 mΩ MAX. (V_{GS} = –10 V, I_D = –18 A)

  $R_{DS(on)2}$ = 37.5 mΩ MAX. (V_{GS} = –4.5 V, I_D = –18 A)
- Low input capacitance

  C_{iss} = 3100 pF TYP.

(TO-263)



ABSOLUTE MAXIMUM RATINGS (T_A = 25°C)

Drain to Source Voltage (V_{GS} = 0 V)	V_{DSS}	–60	V
Gate to Source Voltage (V_{DS} = 0 V)	V_{GSS}	∓20	V
Drain Current (DC) (T_C = 25°C)	$I_{D(DC)}$	∓36	A
Drain Current (pulse) [Note1]	$I_{D(pulse)}$	∓108	A
Total Power Dissipation (T_C = 25°C)	P_{T1}	56	W
Total Power Dissipation (T_A = 25°C)	P_{T2}	1.8	W
Channel Temperature	T_{ch}	175	°C
Storage Temperature	T_{stg}	–55 to +175	°C
Single Avalanche Current [Note2]	I_{AS}	23	A
Single Avalanche Energy [Note2]	E_{AS}	54	mJ

Notes 1. PW ≤ 10 μs, Duty Cycle ≤ 1%

2. Starting T_{ch} = 25°C, V_{DD} = –30 V, R_G = 25 Ω, V_{GS} = –20 → 0 V

THERMAL RESISTANCE

Channel to Case Thermal Resistance	$R_{th(ch-C)}$	2.68	°C/W
Channel to Ambient Thermal Resistance	$R_{th(ch-A)}$	83.3	°C/W

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Document No. D18687EJ3V0DS00 (3rd edition)
Date Published May 2007 NS CP(K)
Printed in Japan

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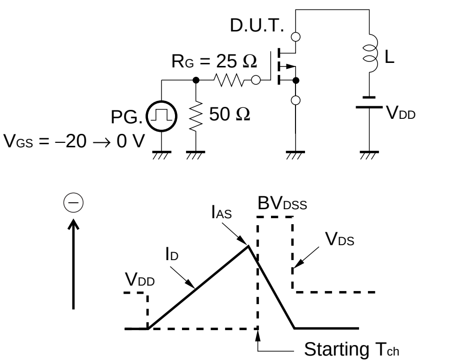
The revised points can be easily searched by copying an "<R>" in the PDF file and specifying it in the "Find what:" field.

ELECTRICAL CHARACTERISTICS (T_A = 25°C)

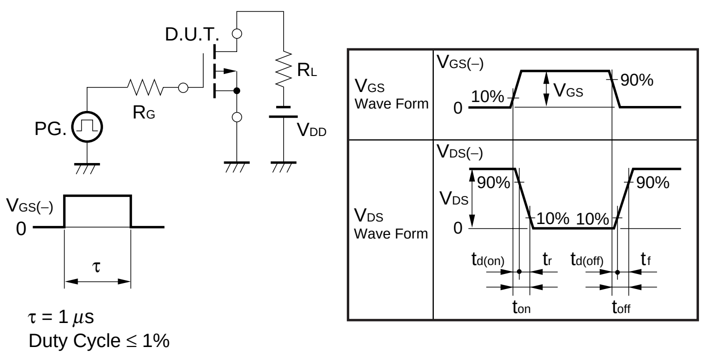
CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Zero Gate Voltage Drain Current	I_{DSS}	V_{DS} = –60 V, V_{GS} = 0 V			–10	μA
Gate Leakage Current	I_{GSS}	V_{GS} = ∓20 V, V_{DS} = 0 V			∓100	nA
Gate to Source Threshold Voltage	$V_{GS(th)}$	V_{DS} = –10 V, I_D = –1 mA	–1.0	–1.6	–2.5	V
Forward Transfer Admittance Note	| y_{fs} |	V_{DS} = –10 V, I_D = –18 A	12	23		S
Drain to Source On-state Resistance Note	$R_{DS(on)1}$	V_{GS} = –10 V, I_D = –18 A		23.1	29.5	mΩ
	$R_{DS(on)2}$	V_{GS} = –4.5 V, I_D = –18 A		27.0	37.5	mΩ
Input Capacitance	C_{iss}	V_{DS} = –10 V,		3100		pF
Output Capacitance	C_{oss}	V_{GS} = 0 V,		350		pF
Reverse Transfer Capacitance	C_{rss}	f = 1 MHz		205		pF
Turn-on Delay Time	$t_{d(on)}$	V_{DD} = –30 V, I_D = –18 A,		8		ns
Rise Time	t_r	V_{GS} = –10 V,		11		ns
Turn-off Delay Time	$t_{d(off)}$	R_G = 0 Ω		210		ns
Fall Time	t_f			110		ns
Total Gate Charge	Q_G	V_{DD} = –48 V,		54		nC
Gate to Source Charge	Q_{GS}	V_{GS} = –10 V,		7		nC
Gate to Drain Charge	Q_{GD}	I_D = –36 A		15		nC
Body Diode Forward Voltage Note	$V_{F(S-D)}$	I_F = –36 A, V_{GS} = 0 V		0.98	1.5	V
Reverse Recovery Time	t_{rr}	I_F = –36 A, V_{GS} = 0 V,		43		ns
Reverse Recovery Charge	Q_{rr}	di/dt = –100 A/μs		56		nC

Note Pulsed test PW ≤ 350 μs, Duty Cycle ≤ 2%

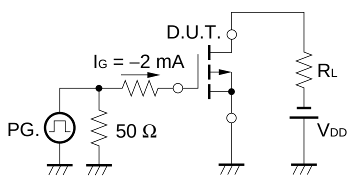
TEST CIRCUIT 1 AVALANCHE CAPABILITY



TEST CIRCUIT 2 SWITCHING TIME

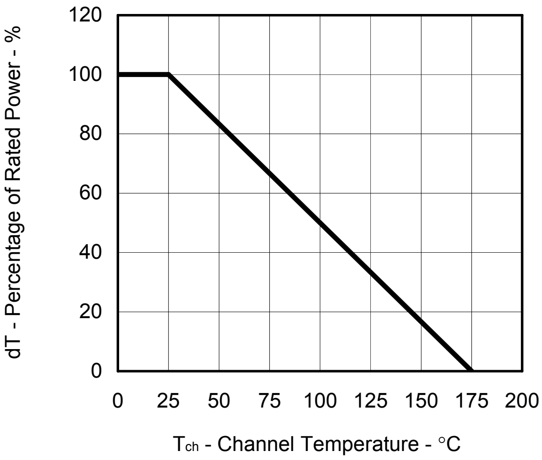


TEST CIRCUIT 3 GATE CHARGE

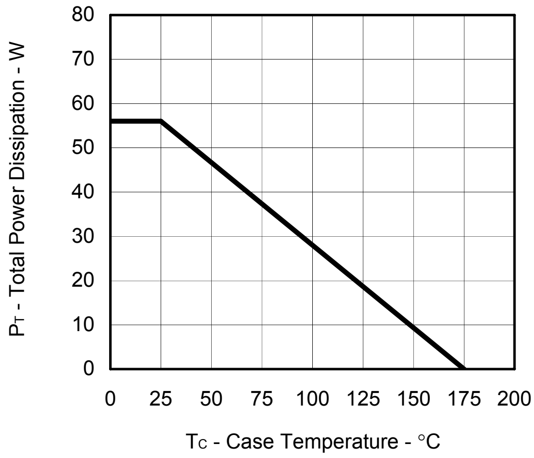


TYPICAL CHARACTERISTICS (T_A = 25°C)

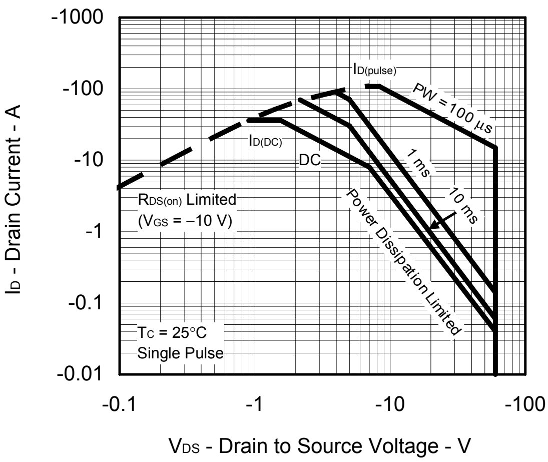
DERATING FACTOR OF FORWARD BIAS SAFE OPERATING AREA



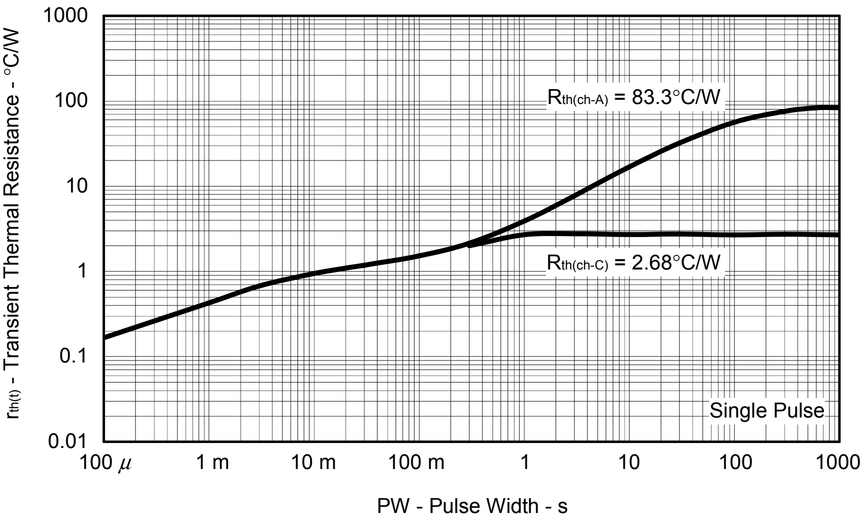
TOTAL POWER DISSIPATION vs. CASE TEMPERATURE



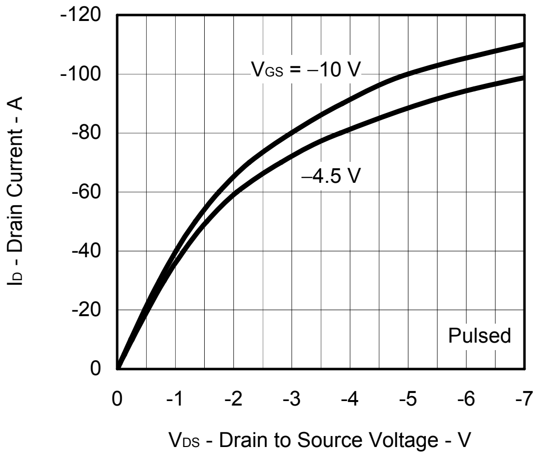
FORWARD BIAS SAFE OPERATING AREA



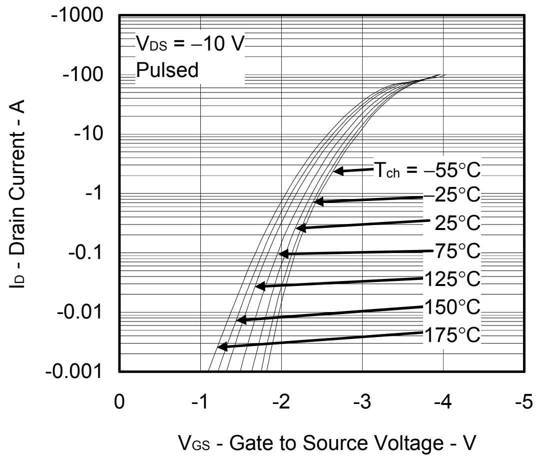
TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH



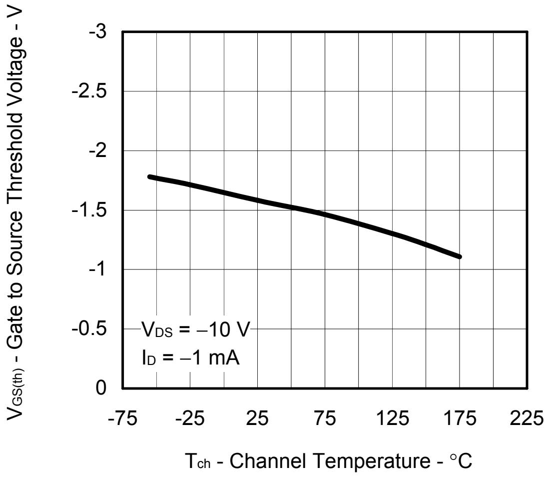
DRAIN CURRENT vs.
DRAIN TO SOURCE VOLTAGE



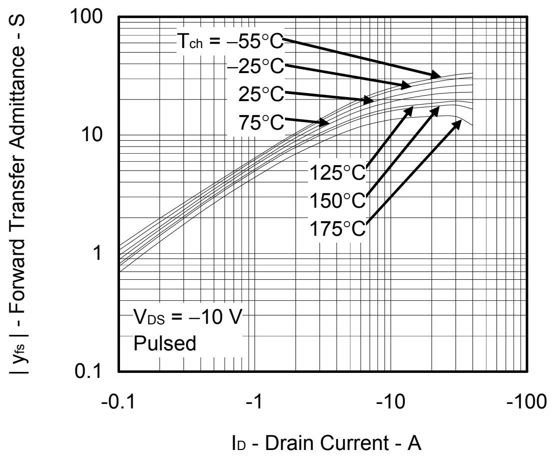
FORWARD TRANSFER CHARACTERISTICS



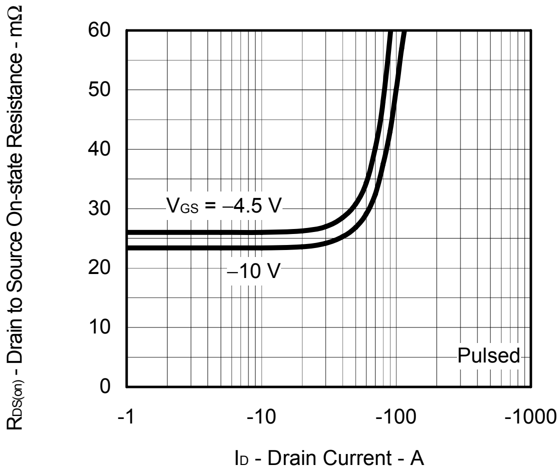
GATE TO SOURCE THRESHOLD VOLTAGE vs.
CHANNEL TEMPERATURE



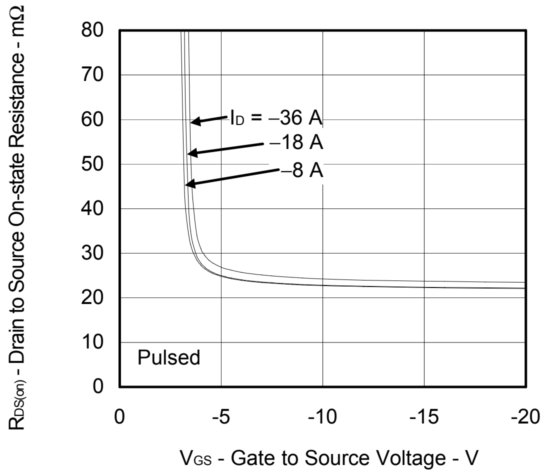
FORWARD TRANSFER ADMITTANCE vs.
DRAIN CURRENT



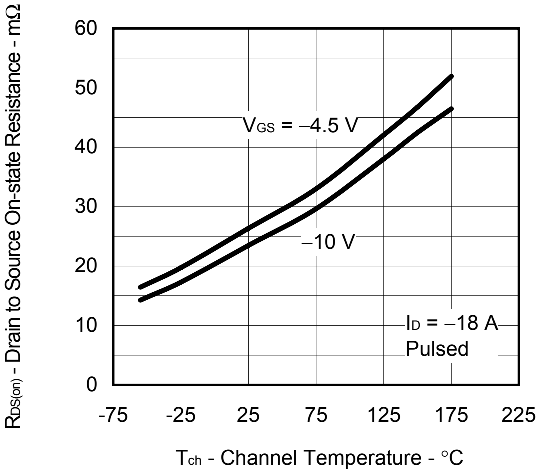
DRAIN TO SOURCE ON-STATE RESISTANCE vs.
DRAIN CURRENT



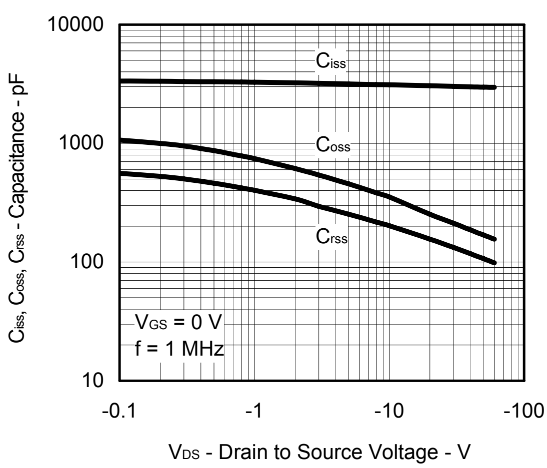
DRAIN TO SOURCE ON-STATE RESISTANCE vs.
GATE TO SOURCE VOLTAGE



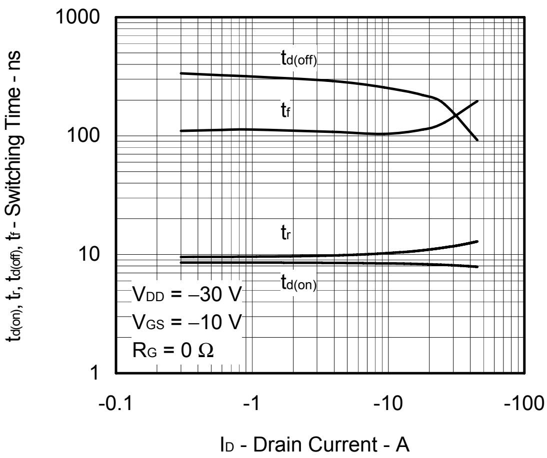
DRAIN TO SOURCE ON-STATE RESISTANCE vs. CHANNEL TEMPERATURE



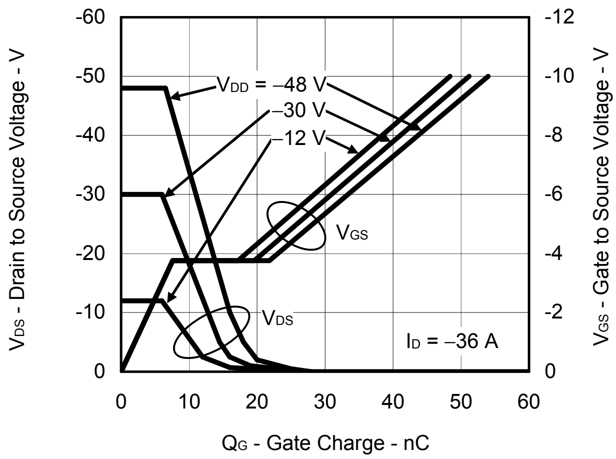
CAPACITANCE vs. DRAIN TO SOURCE VOLTAGE



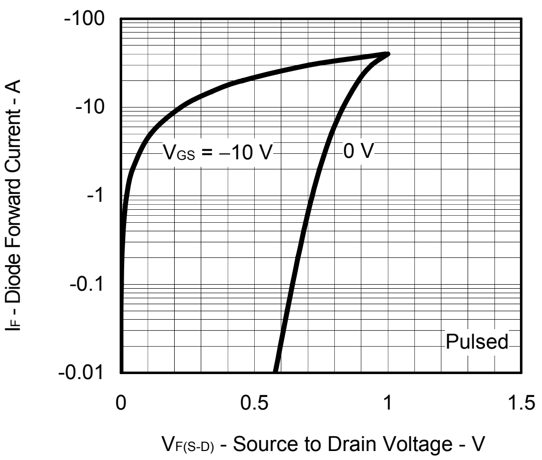
SWITCHING CHARACTERISTICS



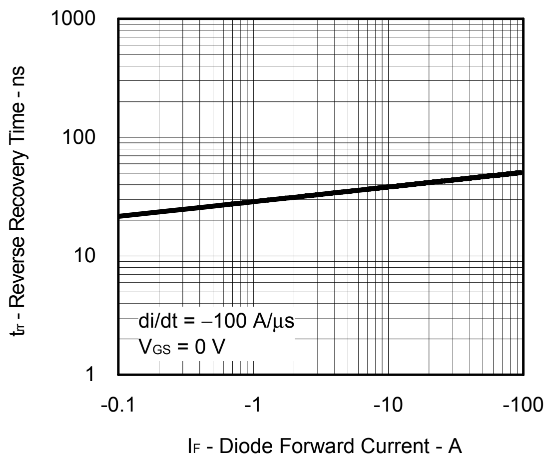
DYNAMIC INPUT/OUTPUT CHARACTERISTICS



SOURCE TO DRAIN DIODE FORWARD VOLTAGE

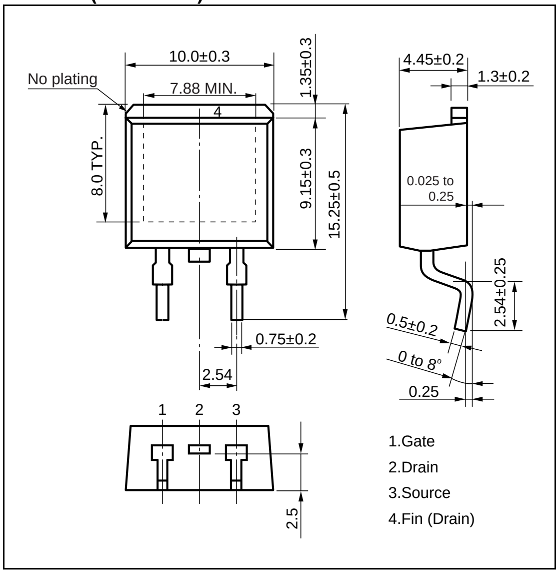


REVERSE RECOVERY TIME vs. DIODE FORWARD CURRENT

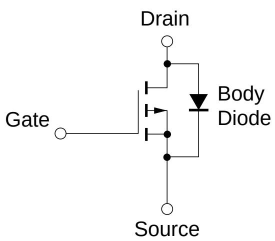


PACKAGE DRAWING (Unit: mm)

TO-263 (MP-25ZK)



EQUIVALENT CIRCUIT



Remark Strong electric field, when exposed to this device, can cause destruction of the gate oxide and ultimately degrade the device operation. Steps must be taken to stop generation of static electricity as much as possible, and quickly dissipate it once, when it has occurred.

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